Daughter Board for Melexis PTC devices



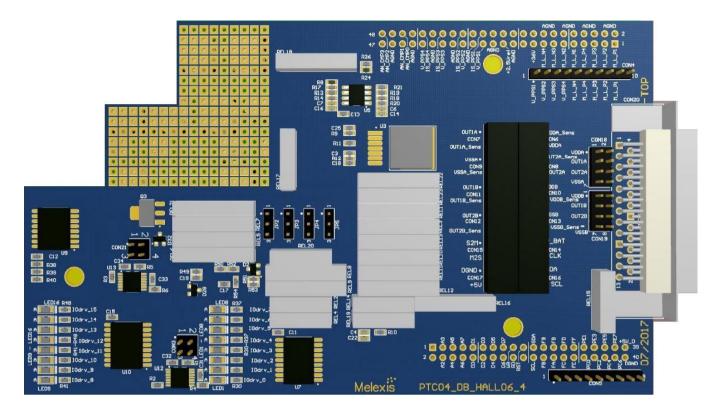


Figure 1: PTC04-DB-HALL06

Features and Benefits

PTC04 interface board for testing devices:

- MLX90371
- MLX90380
- MLX90372
- MLX91372
- MLX90373
- MLX90374
- MLX90378

Applications

Experimental tool for Lab and Prototyping Production Equipment for Serial Programming

Ordering Information

Part No.

PTC04-DB-Hall-06 V4.0

Description

Daughter Board (PCB + rear panel PTC04)

Accessories

Part No.

DLL's for all supported products User Interfaces for supported products Description



Functional Diagram

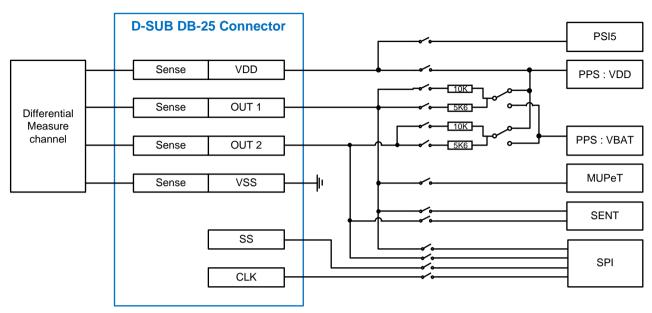


Figure 2: Functional diagram

Contents

| Features and Benefits | 1 |
|---|----|
| Applications | 1 |
| Ordering Information | 1 |
| Accessories | |
| Functional Diagram | 2 |
| Contents | 2 |
| 1. Board description | 3 |
| 1.1. Board Layout | 3 |
| 1.2. Board Schematic | 4 |
| 1.3. Daughter board Connectors | 9 |
| 1.3.1. Digital DB Connector (40 Pins) | 10 |
| 1.3.2. Analog DB Connector (48 Pins) | 10 |
| 1.4. Application Connector | 11 |
| 1.5. Jumper Selection | 16 |
| 1.5.1. CON18 and CON19 – short measuring lines | 16 |
| 1.5.2. J2, J3, J4 and J5 – select pull-up | 17 |
| 1.5.3. CON3 and CON21 – configure MUPeT circuit | 17 |
| 2. Contact | 18 |
| 3. Disclaimer | 18 |



1. Board description

1.1. Board Layout

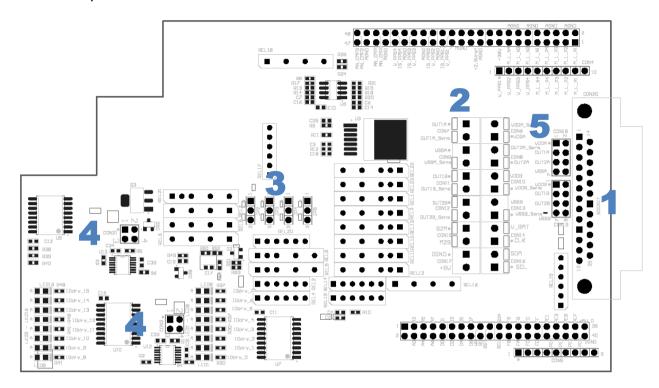


Figure 3: Top layer

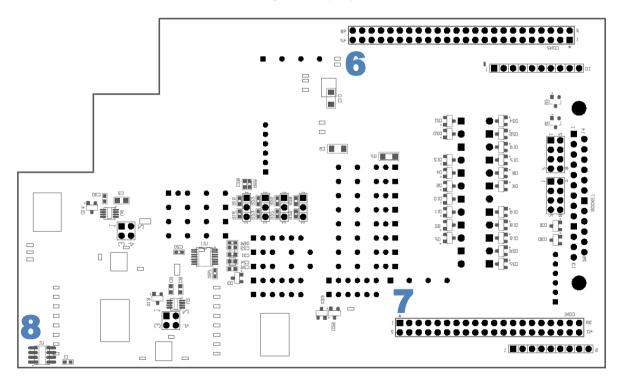


Figure 4: Bottom layer



- 1. DB-25 Connector (CON20): Connector to the application.
- 2. Screw terminal (CON7-16): Alternative connection to the application.
- 3. JP2, JP3, JP4, and JP5: Select 5K6 or 10 K for pull-up load to VDD or Vbat, resp. for OUT1A, OUT2A, OUT1B and OUT2B.
- 4. CON3 and CON21 Jumpers to select a 100 Ohm resistor or the digital potentiometer for MUPeT protocol.
- 5. CON18 and CON19 Jumpers to short the sensing lines at the device connector.
- 6. Analog (CON2) connector.
- 7. Digital (CON1) connector.
- 8. U1 This EEPROM memory keeps a few initial variables in mind. It allows for example to detect what DB is connected to the programmer and if the DB is not expired.

See below for a detailed description on the connectors and the jumper configurations.

1.2. Board Schematic

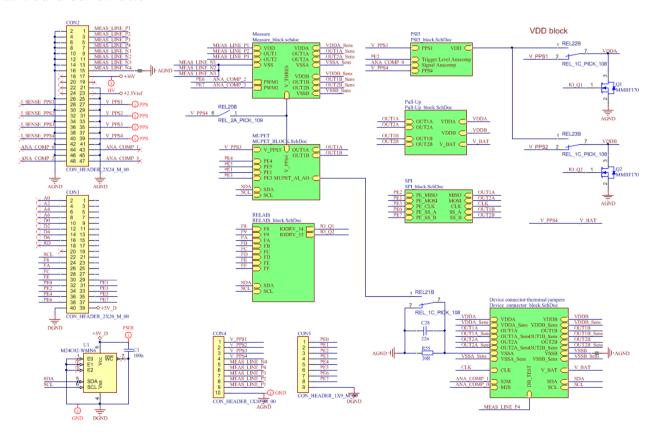


Figure 5: Main schematic



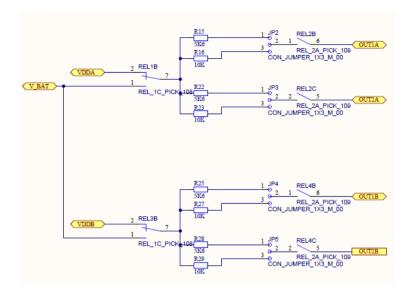


Figure 6: Pull-Up Block

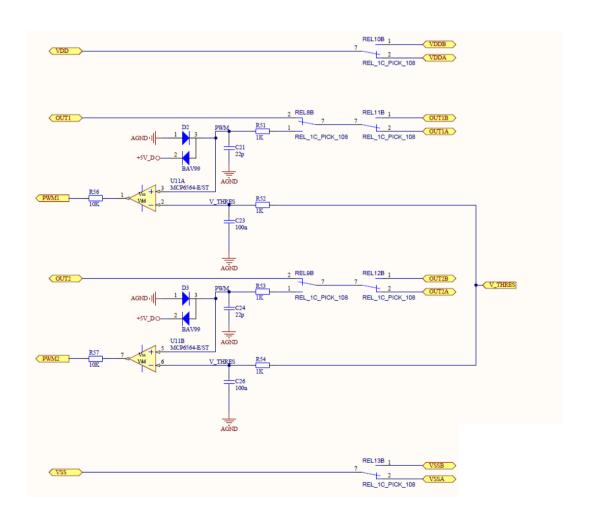


Figure 7: Measure Block



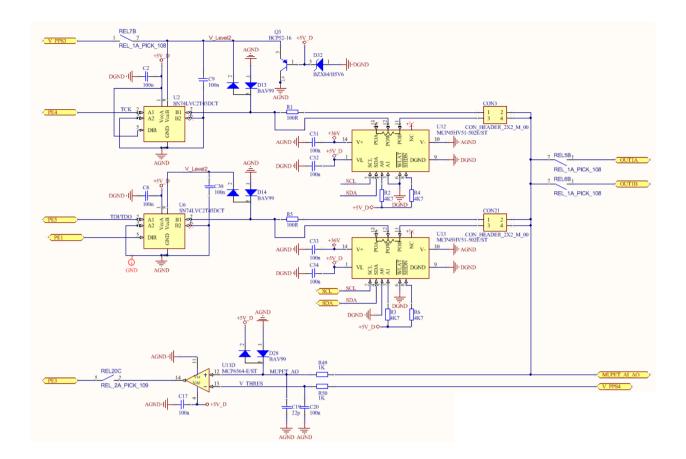


Figure 8: MUPET Block

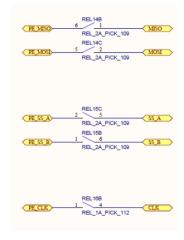


Figure 9: SPI Block



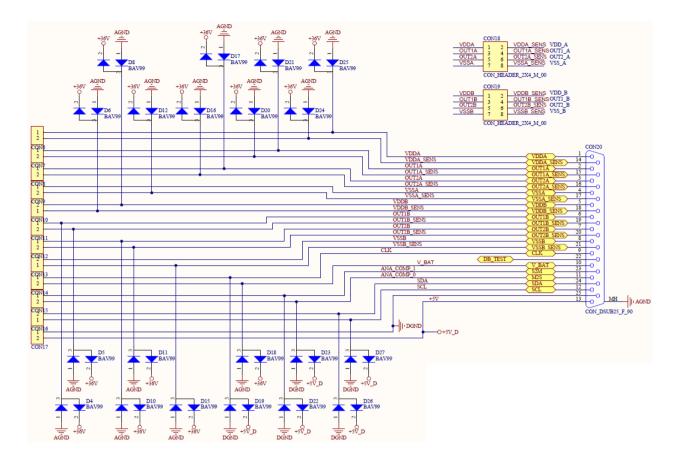


Figure 10: Device Connector Block

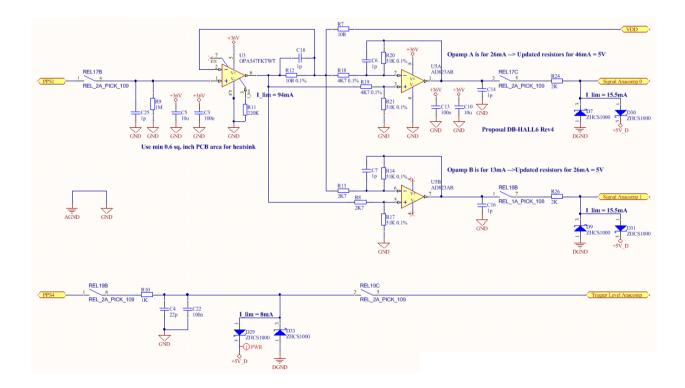


Figure 11: PSI5 Block



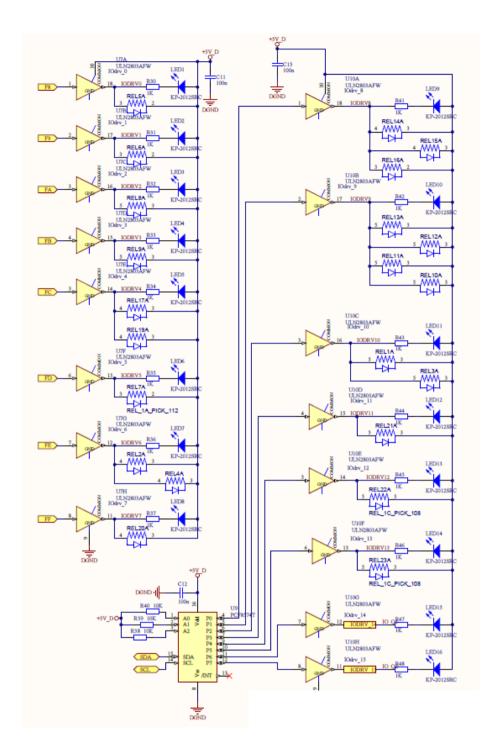


Figure 12: Relays Block



1.3. Daughter board Connectors

The main board has two connectors to the interface with the application. The PTC allows adding a full PCB in between. This daughter board can be mounted on the two connectors. In some exceptional cases, a daughter board contains only a few wires from the Analog connector to the application connector. The pins on of the connectors are described below.

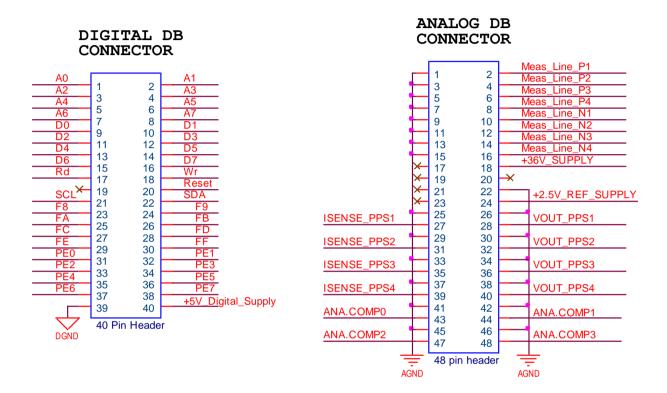


Figure 13: Daughter Board Connectors



1.3.1. Digital DB Connector (40 Pins)

Mainly, the digital connector is meant to expand the programmer to extra needs. Address lines AO-A7 together with the Map Select Lines F8-FF allows to direct access an area of 2 K. Examples would be adding a simple addressed I/O register by using the selection lines. If more complexity is needed, a full FPGA can be mounted on the DB board

| Pins | Names | Description |
|--------|-------------|--|
| 1 – 8 | A0 – A7 | Address lines |
| 9 – 16 | D0 – D7 | Data Lines active during Rd or Wr signals |
| 17 | Rd | Read: A negative pulse will indicate a sampling of the data on the Data Bus |
| 18 | Wr | Write: A Negative pulse will indicate when data is available on the Data Bus |
| 20 | Reset | This signal goes low by powering the PTC or by pressing the reset button. This line can be pulled low by application. Check firmware documentation for resetting by software. |
| 21-22 | SCL / SDA | 12c Bus |
| 23-30 | F8,F9,,FF | CS lines when the address areas are accessed |
| 31-38 | Port E | Note: These pins are limited to 5 Volt input\output!!!! The full Port E of the Atmega core is mounted to these pins. This allows us to use advanced features like PWM, UARTS, Time Measurements, etc By using firmware that supports these, functions, application specific requirements can be fulfilled. |
| 39 | DGND | Digital Ground |
| 40 | +5V Digital | 5 Volt Digital Supply. Maximum current to get out of this supply: 250mA |

Note: All the pins are limited to 5 Volt input\output!!!! However, there are Protections, please take precautions in order to avoid damage of the main board.

1.3.2. Analog DB Connector (48 Pins)

Mainly, the analog connector provides all the analog signals and measure possibilities.

| Pins | Names | Description |
|-------------|---------------|---|
| 28,32,36 | PPS 1-3 | Output of the Programmable Supplies |
| 40 | PPS 4 | Output of the Fast DAC Programmable Power Supply |
| 27,31,35,39 | Isense_PP1-4 | Outputs (Driver outputs before Rsens) for current evaluations. These outputs could be used to connect to the analog comparators in order to create fast digital signals based on current. |
| 2,4,6,8 | ExtMeas1-4Pos | There are 4 differential inputs for making measurements |
| 10,12,14,16 | ExtMeas1_4Neg | The negative inputs of ExtMeas1-4Pos |
| 17,19,21,23 | Shtd_PPS1-4 | Outputs that shows the status of the Drivers. Signals are meant to connect LED's to put the front panel |
| 43,44,47,48 | AnaComp0-3 | Input (limited to 5V) See *Note. Fast Level comparators in order to remove time consuming measurement |
| 18 | +35V_Supply | Supply to extend the daughter board with some extra drivers |
| 24 | +2.5V Ref | Output of internal reference |
| All other | AGND | Analog Ground |

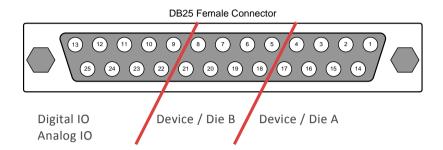
Note: All the pins are limited to 35 Volt input\output!!!! However, there are Protections, please take precautions in order to avoid damage of the main board.

^{*} Note: Some pins are protected and limited to 5 Volt!!!! However, there are Protections, please take precautions in order to avoid damage of the main board.



1.4. Application Connector

The figure and table below shows the connections as provided by the daughterboard PTC04-DB-HALL06. The view of the connector is front view for the female connector of the PTC04-DB-HALL06 which corresponds to the solder side of the male connector. The right side of the connector is used for device / die A, the left side of the connector is used for device / die B.



Additional, there are screw terminals on the Daughterboard that allows you to connect direct to wire.

| PTC0 | 4 | | | 90371 9 | 0372 91372 |
|------|---------|------|--|---------|------------|
| D-SU | B 25 | | | SO | TSSOP |
| Pin | Names | SPI | Description | Pin | Pin |
| 1 | VDDA | VDD | Supply Device A (Minimum required single die connection) | 1 | 3 |
| 2 | OUT1A | MOSI | Output 1 Device A (Minimum required single die connection) | 5 | 15 |
| 3 | OUT2A | MISO | Output 2 Device A | | |
| 4 | VSSA | VSS | Analog Ground Device A (Minimum required single die connection) | 8 | 2 |
| 5 | VDDB | | Supply Device B (Minimum required dual die connection ¹) | | 11 |
| 6 | OUT1B | SS1 | Output 1 Device B (Minimum required dual die connection) | | 6 |
| 7 | OUT2B | SS2 | Output 2 Device B | | |
| 8 | VSSB | | Analog Ground Device B (Minimum required dual die connection) | | 10 |
| 9 | | CLK | SPI CLOCK | | |
| 10 | V_BAT | | Programmable power supply (Max 30mA load) | | |
| 11 | M2S | | Digital IO | | |
| 12 | SCL | | I2C communication | | |
| 13 | +5Vdig | | Digital supply used for I2C devices | | |
| 14 | VDDA_S | | Sensing Supply Device A | 1 | 3 |
| 15 | OUT1A_S | | Sensing Output 1 Device A | 5 | 15 |
| 16 | OUT2A_S | | Sensing Output 2 Device A | | |
| 17 | VSSA_S | | Sensing Analog Ground Device A | 8 | 2 |
| 18 | VDDB_S | | Sensing Supply Device B | | 11 |
| 19 | OUT1B_S | | Sensing Output 1 Device B | | 6 |
| 20 | OUT2B_S | | Sensing Output 2 Device B | | |
| 21 | VSSB_S | | Sensing Analog Ground Device B | | 10 |
| 22 | DB_TEST | | Free measuring line | | |
| 23 | S2M | | Digital IO | | |
| 24 | SDA | | I2C communication | | |
| 25 | DGND | | Digital ground for I2C communication | | |
| MH | AGND | | Metal Housing (shielding of the connector) | | |

¹ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.

Daughter Board for Melexis PTC devices



| PTC0 | 4 | | | 90371 | 90372 |
|-------|---------|------|--|--------------|--------------|
| ם כוו | D OF | | | 90372 | DMD#3 |
| D-SU | Names | SPI | Description | DMP#1 Pin | DMP#2 PIN |
| Pin | | | Description Symply Paying A (Minimum required single disconnection) | | |
| 1 | VDDA | VDD | Supply Device A (Minimum required single die connection) | 2 | 3 |
| 2 | OUT1A | MOSI | Output 1 Device A (Minimum required single die connection) | 3 | 1 |
| 3 | OUT2A | MISO | Output 2 Device A | 4 | 2 |
| 4 | VSSA | VSS | Analog Ground Device A (Minimum required single die connection) | 4 | 2 |
| 5 | VDDB | | Supply Device B (Minimum required dual die connection ²) | | |
| 6 | OUT1B | SS1 | Output 1 Device B (Minimum required dual die connection) | | |
| 7 | OUT2B | SS2 | Output 2 Device B | | |
| 8 | VSSB | | Analog Ground Device B (Minimum required dual die connection) | | |
| 9 | | CLK | SPI CLOCK | | |
| 10 | V_BAT | | Programmable power supply (Max 30mA load) | | |
| 11 | M2S | | Digital IO | | |
| 12 | SCL | | I2C communication | | |
| 13 | +5Vdig | | Digital supply used for I2C devices | | |
| 14 | VDDA_S | | Sensing Supply Device A | 2 | 3 |
| 15 | OUT1A_S | | Sensing Output 1 Device A | 3 | 1 |
| 16 | OUT2A_S | | Sensing Output 2 Device A | | |
| 17 | VSSA_S | | Sensing Analog Ground Device A | 4 | 2 |
| 18 | VDDB_S | | Sensing Supply Device B | | |
| 19 | OUT1B_S | | Sensing Output 1 Device B | | |
| 20 | OUT2B S | | Sensing Output 2 Device B | | |
| 21 | VSSB S | | Sensing Analog Ground Device B | | |
| 22 | DB_TEST | | Free measuring line | | |
| 23 | S2M | | Digital IO | | |
| 24 | SDA | | I2C communication | | |
| 25 | DGND | | Digital ground for I2C communication | | |
| МН | AGND | | Metal Housing (shielding of the connector) | | |

² In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.

Daughter Board for Melexis PTC devices



| PTC0 | 4 | | | 90373 | |
|------|---------|------|--|-------|-------|
| D-SU | B 25 | | | DMP | TSSOP |
| Pin | Names | SPI | Description | Pin | Pin |
| 1 | VDDA | VDD | Supply Device A (Minimum required single die connection) | 2 | 3 |
| 2 | OUT1A | MOSI | Output 1 Device A (Minimum required single die connection) | | |
| 3 | OUT2A | MISO | Output 2 Device A | | |
| 4 | VSSA | VSS | Analog Ground Device A (Minimum required single die connection) | 4 | 2 |
| 5 | VDDB | | Supply Device B (Minimum required dual die connection ³) | | 11 |
| 6 | OUT1B | SS1 | Output 1 Device B (Minimum required dual die connection) | | |
| 7 | OUT2B | SS2 | Output 2 Device B | | |
| 8 | VSSB | | Analog Ground Device B (Minimum required dual die connection) | | 10 |
| 9 | | CLK | SPI CLOCK | | |
| 10 | V_BAT | | Programmable power supply (Max 30mA load) | | |
| 11 | M2S | | Digital IO | | |
| 12 | SCL | | I2C communication | | |
| 13 | +5Vdig | | Digital supply used for I2C devices | | |
| 14 | VDDA_S | | Sensing Supply Device A | 2 | 3 |
| 15 | OUT1A_S | | Sensing Output 1 Device A | | |
| 16 | OUT2A_S | | Sensing Output 2 Device A | | |
| 17 | VSSA_S | | Sensing Analog Ground Device A | 4 | 2 |
| 18 | VDDB_S | | Sensing Supply Device B | | 11 |
| 19 | OUT1B_S | | Sensing Output 1 Device B | | |
| 20 | OUT2B_S | | Sensing Output 2 Device B | | |
| 21 | VSSB_S | | Sensing Analog Ground Device B | | 10 |
| 22 | DB_TEST | | Free measuring line | | |
| 23 | S2M | | Digital IO | | |
| 24 | SDA | | I2C communication | | |
| 25 | DGND | | Digital ground for I2C communication | | |
| МН | AGND | | Metal Housing (shielding of the connector) | | |

³ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.



| Pin Names SPI Description Pin | PTC04 | | | | 903 | 74 | |
|--|-------|---------|------|--|-----|-----|-------|
| Pin Names SPI Description Pin Pir Pire Pir Pire Pir Pin | | | | | | 9 | 0378 |
| 1 VDDA VDD Supply Device A (Minimum required single die connection) 3 1 3 2 OUT1A MOSI Output 1 Device A (Minimum required single die connection) 1 5 15 3 OUT2A MISO Output 2 Device A 4 3 3 4 VSSA VSS Analog Ground Device A (Minimum required single die connection) 2 8 2 5 VDDB Supply Device B (Minimum required dual die connection) 7 1 <th>D-SUE</th> <th>3 25</th> <th></th> <th></th> <th>DMP</th> <th>SO</th> <th>TSSOP</th> | D-SUE | 3 25 | | | DMP | SO | TSSOP |
| OUT1A MOSI Output 1 Device A (Minimum required single die connection) OUT2A MISO Output 2 Device A VSSA VSS Analog Ground Device A (Minimum required single die connection) Supply Device B (Minimum required dual die connection) OUT1B SS1 Output 1 Device B (Minimum required dual die connection) OUT2B SS2 Output 1 Device B (Minimum required dual die connection) OUT2B SS2 Output 2 Device B (Minimum required dual die connection) CLK SPI CLOCK OUT2B SPI CLOCK Programmable power supply (Max 30mA load) LI M2S Digital IO SCL I2C communication Digital supply used for I2C devices VDDA_S Sensing Supply Device A Sensing Output 1 Device A Sensing Output 1 Device A Sensing Output 2 Device A VDDB_S Sensing Supply Device A Sensing Supply Device B OUT1B_Sensing Output 1 Device B Sensing Output 2 Device B DUT1B_Sensing Output 1 Device B Sensing Output 2 Device B DUT1B_Sensing Output 1 Device B Sensing Output 2 Device B DUT1B_Sensing Output 2 Device B Sensing Output 1 Device B DUT1B_Sensing Output 2 Device B DUT1B_Sensing Output 2 Device B Sensing Output 1 Device B DUT1B_Sensing Output 2 Device B DUT1B_Sensing Output 3 Device B DUT1B_Sensing Output 4 Device B DUT1B_Sensing Output 5 Device B DUT1B_Sensing Output 6 Device B DUT1B_Sensing Output 7 Device B DUT1B_Sensing Output 9 D | Pin | Names | SPI | Description | Pin | Pin | Pin |
| OUT2A MISO Output 2 Device A 4 3 13 VSSA VSS Analog Ground Device A (Minimum required single die connection) 2 8 2 VDDB Supply Device B (Minimum required dual die connection 1) 13 OUT1B SS1 Output 1 Device B (Minimum required dual die connection 1) 7 OUT2B SS2 Output 2 Device B (Minimum required dual die connection) 7 OUT2B SS2 Output 2 Device B (Minimum required dual die connection) 10 CLK SPI CLOCK OUT2B SS2 Output 2 Device B (Minimum required dual die connection) 10 CLK SPI CLOCK DUT2B SS2 Digital IO 12 SCL 12C communication 12 I2C communication 13 +5Vdig Digital supply used for 12C devices 14 VDDA_S Sensing Supply Device A 1 5 15 15 15 15 15 15 15 15 15 15 15 15 | 1 | VDDA | VDD | Supply Device A (Minimum required single die connection) | 3 | 1 | 3 |
| 4 VSSA VSS Analog Ground Device A (Minimum required single die connection) 2 8 2 5 VDDB Supply Device B (Minimum required dual die connection) 12 6 OUT1B SS1 Output 1 Device B (Minimum required dual die connection) 7 7 OUT2B SS2 Output 2 Device B 5 8 VSSB Analog Ground Device B (Minimum required dual die connection) 10 9 CLK SPI CLOCK 10 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL 12C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 15 16 OUT2A_ Sensing Analog Ground Device A 2 8 2 17 VSSA_S Sensing Output 1 Device B 1 1 19 OUT1B_ Sensing Output 2 Device B 5 20 OUT2 | 2 | OUT1A | MOSI | Output 1 Device A (Minimum required single die connection) | 1 | 5 | 15 |
| Supply Device B (Minimum required dual die connection 4) OUT1B SS1 Output 1 Device B (Minimum required dual die connection) OUT2B SS2 Output 2 Device B NSSB Analog Ground Device B (Minimum required dual die connection) CLK SPI CLOCK UBAT Programmable power supply (Max 30mA load) M2S Digital IO SCL I2C communication JECUAL SPICLOCK UDDA_S Sensing Supply Device A SUUT1A_Sensing Output 1 Device A SUUT1A_Sensing Output 1 Device A Supply Device B Supply | 3 | OUT2A | MISO | Output 2 Device A | 4 | 3 | 13 |
| 6 OUT1B SS1 Output 1 Device B (Minimum required dual die connection) 7 7 OUT2B SS2 Output 2 Device B 5 8 VSSB Analog Ground Device B (Minimum required dual die connection) 10 9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 5 15 S Sensing Output 2 Device A 4 3 13 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 12 19 OUT2B_ Sensing Output 1 Device B 5 S Sensing Output 1 Device B 5 S Sensing Output 2 Device B 5 S Sensing Output 3 Device B 5 S Sensing Output 3 Device B 5 S Sensing Output 4 Device B 5 S Sensing Output 5 Device B 5 S Sensing Output 6 Device B 6 7 S Sensing Output 6 Device B 7 S Sensing Output 7 Device B 7 S Sensing Output 8 Device B 7 S Sensing Output 9 Device 9 8 S Sensing Output 9 Device 9 8 S Sensing Output 9 Device 9 8 S | 4 | VSSA | VSS | Analog Ground Device A (Minimum required single die connection) | 2 | 8 | 2 |
| 7 OUT2B SS2 Output 2 Device B 8 VSSB Analog Ground Device B (Minimum required dual die connection) 9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_Sensing Output 1 Device A S 16 OUT2A_Sensing Output 2 Device A S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B S 20 OUT2B_Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B S 22 DB_TEST Free measuring line Digital IO | 5 | VDDB | | Supply Device B (Minimum required dual die connection ⁴) | | | 11 |
| 8 VSSB Analog Ground Device B (Minimum required dual die connection) 9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 19 S 16 OUT2A_ Sensing Output 2 Device A 4 3 12 S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 12 19 OUT1B_ Sensing Output 1 Device B S 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B S 22 DB_TEST Free measuring line 23 S2M Digital IO | 6 | OUT1B | SS1 | Output 1 Device B (Minimum required dual die connection) | | | 7 |
| 9 CLK SPI CLOCK 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 15 OUT1A_ Sensing Output 1 Device A 16 OUT2A_ Sensing Output 2 Device A 17 VSSA_S Sensing Analog Ground Device A 18 VDDB_S Sensing Supply Device B 19 OUT1B_ Sensing Output 1 Device B 20 OUT2B_ Sensing Output 2 Device B 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST 23 S2M Digital IO | 7 | OUT2B | SS2 | Output 2 Device B | | | 5 |
| 10 V_BAT Programmable power supply (Max 30mA load) 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 19 S 16 OUT2A_ Sensing Output 2 Device A 4 3 13 S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 12 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 5 S 22 DB_TEST Free measuring line 5 S2M Digital IO | 8 | VSSB | | Analog Ground Device B (Minimum required dual die connection) | | | 10 |
| 11 M2S Digital IO 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 1! S 16 OUT2A_ Sensing Output 2 Device A 4 3 1: S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 1: S 20 OUT2B_ Sensing Output 1 Device B S 21 VSSB_S Sensing Analog Ground Device B 5 S 22 DB_TEST Free measuring line 52M Digital IO | 9 | | CLK | SPI CLOCK | | | |
| 12 SCL I2C communication 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 1! S 16 OUT2A_ Sensing Output 2 Device A 4 3 1! S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 1! 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 5 23 S2M Digital IO | 10 | V_BAT | | Programmable power supply (Max 30mA load) | | | |
| 13 +5Vdig Digital supply used for I2C devices 14 VDDA_S Sensing Supply Device A 3 1 3 15 OUT1A_ Sensing Output 1 Device A 1 5 1! S 16 OUT2A_ Sensing Output 2 Device A 4 3 1: S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 1: 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 10 23 S2M Digital IO | 11 | M2S | | Digital IO | | | |
| 14VDDA_SSensing Supply Device A31315OUT1A_ SSensing Output 1 Device A151!16OUT2A_ SSensing Output 2 Device A431:17VSSA_SSensing Analog Ground Device A28218VDDB_SSensing Supply Device B1:19OUT1B_ SSensing Output 1 Device B720OUT2B_ SSensing Output 2 Device B521VSSB_SSensing Analog Ground Device B1022DB_TESTFree measuring line23S2MDigital IO | 12 | SCL | | I2C communication | | | |
| 15 OUT1A_ Sensing Output 1 Device A 1 5 19 16 OUT2A_ Sensing Output 2 Device A 4 3 19 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 19 19 OUT1B_ Sensing Output 1 Device B 7 19 Sensing Output 2 Device B 5 20 OUT2B_ Sensing Output 2 Device B 5 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 10 23 S2M Digital IO | 13 | +5Vdig | | Digital supply used for I2C devices | | | |
| S 16 OUT2A_ Sensing Output 2 Device A 4 3 13 S 17 VSSA_S Sensing Analog Ground Device A 2 8 2 18 VDDB_S Sensing Supply Device B 12 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 23 S2M Digital IO | 14 | VDDA_S | | Sensing Supply Device A | 3 | 1 | 3 |
| S 17 VSSA_S Sensing Analog Ground Device A 18 VDDB_S Sensing Supply Device B 19 OUT1B_ Sensing Output 1 Device B S 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO | 15 | _ | | Sensing Output 1 Device A | 1 | 5 | 15 |
| 18 VDDB_S Sensing Supply Device B 19 OUT1B_ Sensing Output 1 Device B 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO | 16 | _ | | Sensing Output 2 Device A | 4 | 3 | 13 |
| 19 OUT1B_ Sensing Output 1 Device B 7 S 20 OUT2B_ Sensing Output 2 Device B 5 S 21 VSSB_S Sensing Analog Ground Device B 10 22 DB_TEST Free measuring line 23 S2M Digital IO | 17 | VSSA_S | | Sensing Analog Ground Device A | 2 | 8 | 2 |
| S 20 OUT2B_ Sensing Output 2 Device B S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO | 18 | VDDB_S | | Sensing Supply Device B | | | 11 |
| S 21 VSSB_S Sensing Analog Ground Device B 22 DB_TEST Free measuring line 23 S2M Digital IO | 19 | _ | | Sensing Output 1 Device B | | | 7 |
| 22 DB_TEST Free measuring line 23 S2M Digital IO | 20 | _ | | Sensing Output 2 Device B | | | 5 |
| 23 S2M Digital IO | 21 | VSSB_S | | Sensing Analog Ground Device B | | | 10 |
| | 22 | DB_TEST | | Free measuring line | | | |
| 0.4 | 23 | S2M | | Digital IO | | | |
| 24 SDA I2C communication | 24 | SDA | | I2C communication | | | |
| 25 DGND Digital ground for I2C communication | 25 | DGND | | Digital ground for I2C communication | | | |
| MH AGND Metal Housing (shielding of the connector) | MH | AGND | | Metal Housing (shielding of the connector) | | | |

⁴ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.

Daughter Board for Melexis PTC devices



| PTC0 | 4 | | | 90380 | | |
|------|---------|------|--|-------|-----|-------|
| D-SU | B 25 | | | DMP | SO | TSSOP |
| Pin | Names | SPI | Description | Pin | Pin | Pin |
| 1 | VDDA | VDD | Supply Device A (Minimum required single die connection) | 2 | 6/7 | 14/15 |
| 2 | OUT1A | MOSI | Output 1 Device A (Minimum required single die connection) | 3 | 8 | 16 |
| 3 | OUT2A | MISO | Output 2 Device A | 1 | 5 | 13 |
| 4 | VSSA | VSS | Analog Ground Device A (Minimum required single die connection) | 4 | 1 | 1 |
| 5 | VDDB | | Supply Device B (Minimum required dual die connection ⁵) | | | 6/7 |
| 6 | OUT1B | SS1 | Output 1 Device B (Minimum required dual die connection) | | | 8 |
| 7 | OUT2B | SS2 | Output 2 Device B | | | 5 |
| 8 | VSSB | | Analog Ground Device B (Minimum required dual die connection) | | | 9 |
| 9 | | CLK | SPI CLOCK | | | |
| 10 | V_BAT | | Programmable power supply (Max 30mA load) | | | |
| 11 | M2S | | Digital IO | | | |
| 12 | SCL | | I2C communication | | | |
| 13 | +5Vdig | | Digital supply used for I2C devices | | | |
| 14 | VDDA_S | | Sensing Supply Device A | 2 | 6/7 | 14/15 |
| 15 | OUT1A_S | | Sensing Output 1 Device A | 3 | 8 | 16 |
| 16 | OUT2A_S | | Sensing Output 2 Device A | 1 | 5 | 13 |
| 17 | VSSA_S | | Sensing Analog Ground Device A | 4 | 1 | 1 |
| 18 | VDDB_S | | Sensing Supply Device B | | | 6/7 |
| 19 | OUT1B_S | | Sensing Output 1 Device B | | | 8 |
| 20 | OUT2B_S | | Sensing Output 2 Device B | | | 5 |
| 21 | VSSB_S | | Sensing Analog Ground Device B | | | 9 |
| 22 | DB_TEST | | Free measuring line | | | |
| 23 | S2M | | Digital IO | | | |
| 24 | SDA | | I2C communication | | | |
| 25 | DGND | | Digital ground for I2C communication | | | |
| МН | AGND | | Metal Housing (shielding of the connector) | | | |

⁵ In case of a dual die connection with a common supply in the application (common VDD), only the VDDA pin of the daughter board device connector needs to be connected.



1.5. Jumper Selection

1.5.1. CON18 and CON19 – short measuring lines

The D-SUP DB-25 connector of the daughter board is equipped with a sensing line for each analog device pin.

The top row is the force line of the device pins. The bottom row is the sensing line of the device pins.

Between each force and sense line there is a jumper to short the sense line at the DB-25 connector on the daughter board.

The jumper is placed when the external sensing is not required. For example: an application with a digital or PWM output.

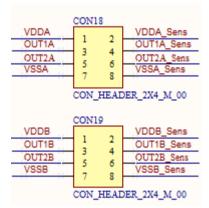
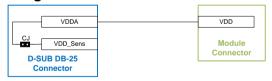


Figure 14: Jumper between force and sense line.

Single wire connection



When the jumper is closed, only one wire is required **per pin** between the PTC-04 and the module or sensor.

In the table above these pins are marked as "Minimum required single/dual die connection".

In this configuration the measurement of VDD, OUT1 or OUT2 is done at the D-SUB DB-25 connector of the PTC04-DB-HALL06.

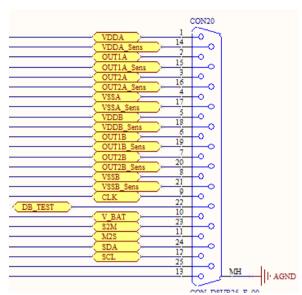


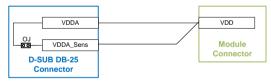
Figure 15: DB-25 device connector.

CON18 and CON19 are used to short the force and sense line of the analog device pins.

In other words, they are used to select single wire or double wire connection to the pin of the module / sensor.

- CON18 → Device / Die A
- CON19 → Device / Die B

Double wire connection



When the jumper is open, two wires are required **per pin** between the PTC-04 and the module or sensor.

With two wires connected at the module side, the measurement of VDD, OUT1 or OUT2 is done on the module or sensor connector.

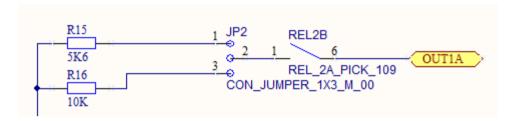
The external sensing line per pin is only required for applications with an analog sensor output and where a higher measuring accuracy is required.



1.5.2. J2, J3, J4 and J5 – select pull-up

These jumpers are used to select the pull-up resistor for the outputs of die A and B:

- JP2: Pull-up selection for OUT1 die A
- JP3: Pull-up selection for OUT2 die A
- JP4: Pull-up selection for OUT1 die B
- JP5: Pull-up selection for OUT2 die B



Place the jumper between:

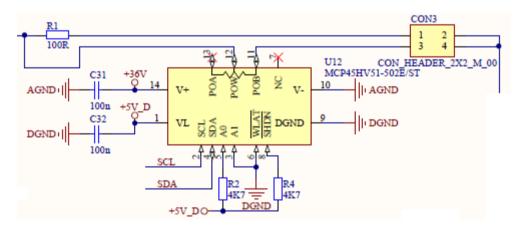
- Pin 1 and 2 → select 5K6 Pull-up
- Pin 3 and 2 → select 10K Pull-up

The selection between VDD and Vbat is done by a relay on software level. When Vbat is set to 0V one can select a pull-down

1.5.3. CON3 and CON21 – configure MUPeT circuit

The MUPeT circuit on the daughter board is used to convert the clock and data of the UART to a single wire protocol called MUPeT.

CON3 and CON21 are used to configure the resistors of the MUPeT circuit in function of the output resistance on the sensor/module.



- Pin 1 and 2 \rightarrow select 100 Ω
- Pin 3 and 4 → select digital potentiometer

PTC04-DB-HALL06

Daughter Board for Melexis PTC devices



2. Contact

For the latest version of this document, go to our website at www.melexis.com. For additional information, please contact our Direct Sales team and get help for your specific needs:

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PTC04-DB-HALL06



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